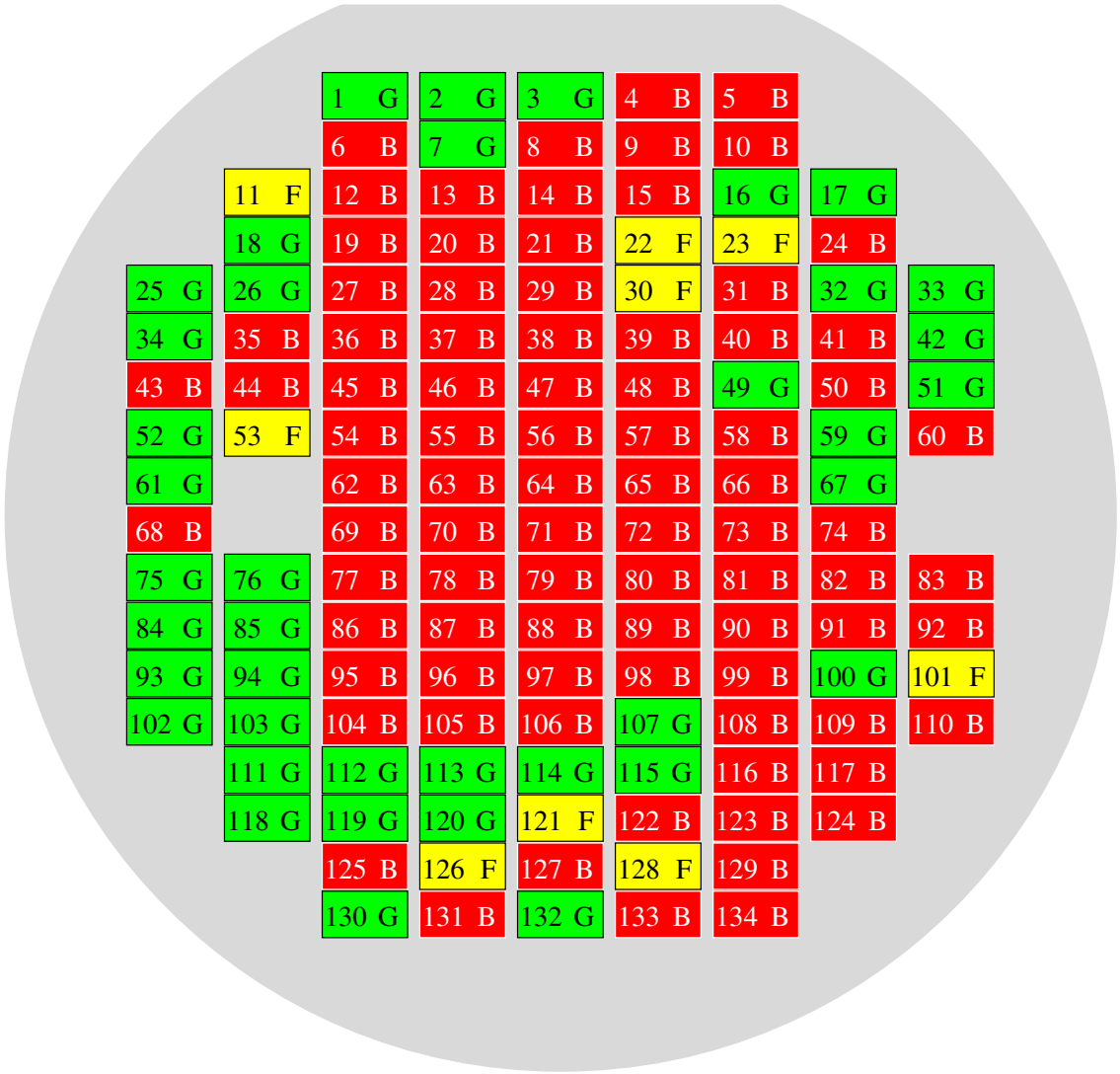
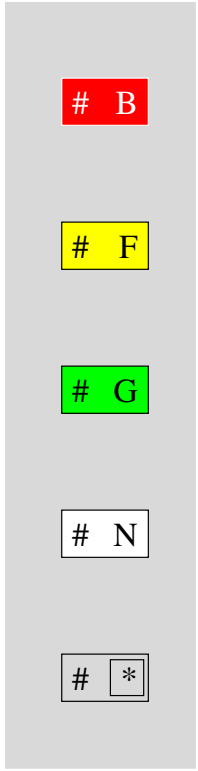
Die quality map for wafer 243 s/n: 21316-16-08

Date: 12/21/99





Bad die

Fair die

Good die

No info

Manually tagged